

<b>Notice of References Cited</b>	Application/Control No. 10/627,290	Applicant(s)/Patent Under Reexamination USTUNER ET AL.	
	Examiner Jaworski Francis J.	Art Unit 3737	Page 1 of 1

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	B	US-4,631,710	12-1986	Yamaguchi et al.	367/103
	C	US-6,682,483	01-2004	Abend et al.	600/437
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**NON-PATENT DOCUMENTS**

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	U	Sowelam, S. et al "Sparse Periodic Transducer Arrays Using the Effective Aperture Concept" □□GE R&D Tech Rept 98CRD187 December 1998
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.